

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10624120	LEE ET AL.
	Examiner	Art Unit
	JACQUELINE CHENG	3768

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
see attached search history	2/19/08	jc

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner